

Notice of References Cited	Application/Control No. 10/811,897	Applicant(s)/Patent Under Reexamination CHO ET AL.	
	Examiner Theresa Trieu	Art Unit 3748	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,311,292	03-1967	Connor	417/372
*	B	US-4,472,114	09-1984	Fujiwara et al.	417/372
*	C	US-6,860,724	03-2005	Cho et al.	418/29
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 60030495 A	02-1985	Japan	TAGAWA et al.	F04C 29/02
	O	JP 61155688 A	07-1986	Japan	KANEUCHI et al.	F04C 29/02
	P	JP 62271987 A	11-1987	Japan	TAKEBAYASHI et al.	F04C 29/02
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.